

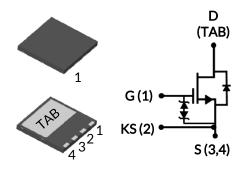


$650V\text{-}45m\Omega\,\text{SiC}\,\text{FET}$

Rev. B, January 2020

DATASHEET

UF3SC065040D8S



Part Number	Package	Marking
UF3SC065040D8S	DFN8X8-4L	UF3SC065040D8S



Description

This SiC FET device is based on a unique 'cascode' circuit configuration, in which a normally-on SiC JFET is co-packaged with a Si MOSFET to produce a normally-off SiC FET device. The device's standard gate-drive characteristics allows for a true "drop-in replacement" to Si IGBTs, Si FETs, SiC MOSFETs or Si superjunction devices. Available in the DFN8X8-4L package, this device exhibits ultra-low gate charge and exceptional reverse recovery characteristics, making it ideal for switching inductive loads, and any application requiring standard gate drive.

Features

- Typical on-resistance $R_{DS(on),typ}$ of $45m\Omega$
- Maximum operating temperature of 150°C
- Excellent reverse recovery
- Low gate charge
- Low intrinsic capacitance
- ESD protected, HBM class 2
- DFN8X8-4L package for faster switching, clean gate waveforms

Typical applications

- EV charging
- PV inverters
- Switch mode power supplies
- Power factor correction modules
- Motor drives
- Induction heating





Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		650	V
Gate-source voltage	V _{GS}	DC	-25 to +25	V
Continuous drain current ¹	I _D	T _C < 120°C	18	А
Pulsed drain current ²	I _{DM}	T _C = 25°C	110	А
Single pulsed avalanche energy ³	E _{AS}	L=15mH, I _{AS} =3.19A	76	mJ
Power dissipation	P _{tot}	T _C = 25°C	125	W
Maximum junction temperature	T _{J,max}		150	°C
Operating and storage temperature	T _J , T _{STG}		-55 to 150	°C
Reflow soldering temperature	T _{solder}	reflow MSL 3	260	°C

1. Limited by bondwires

2. Pulse width t_p limited by $T_{J,max}$

3. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{ ext{ hetaJC}}$			0.8	1	°C/W









Electrical Characteristics (T_J = +25°C unless otherwise specified)

Typical Performance - Static

Devenetor	Symbol	Test Conditions			11.20		
Parameter			Min	Тур	Max	- Units	
Drain-source breakdown voltage	BV _{DS}	V _{GS} =0V, I _D =1mA	650			V	
Total drain leakage current		V _{DS} =650V, V _{GS} =0V, T _J =25°C		0.7	150		
	I _{DSS}	V _{DS} =650V, V _{GS} =0V, T _J =150°C		5		μA	
Total gate leakage current	I _{GSS}	V _{DS} =0V, T _J =25°C, V _{GS} =-20V / +20V		6	±20	μA	
Drain-source on-resistance	R _{DS(on)}	V _{GS} =12V, I _D =20A, T _J =25°C		45	58		
		V _{GS} =12V, I _D =20A, T _J =125°C		67		mΩ	
		V _{GS} =12V, I _D =20A, T _J =150°C		70			
Gate threshold voltage	V _{G(th)}	V_{DS} =5V, I_{D} =10mA	4	5	6	V	
Gate resistance	R _G	f=1MHz, open drain		4.5		Ω	

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions		Units		
			Min	Тур	Max	Units
Diode continuous forward current ¹	ls	T _C < 120°C			18	А
Diode pulse current ²	I _{S,pulse}	T _C =25°C			110	А
Forward voltage	V _{FSD}	V _{GS} =0V, I _F =10A, T _J =25°C		1.2	1.7	V
		V _{GS} =0V, I _F =10A, T _J =150°C		1.25		
Reverse recovery charge	Q _{rr}	V_{R} =400V, I _F =20A, V_{GS} =-5V, R _{G_EXT} =10Ω di/dt=1380A/µs, T _J =25°C		185		nC
Reverse recovery time	t _{rr}			29		ns
Reverse recovery charge	Q _{rr}	V_{R} =400V, I _F =20A, V_{GS} =-5V, $R_{G_{EXT}}$ =10 Ω		169		nC
Reverse recovery time	t _{rr}	di/dt=1380A/µs, Tj=150°C		28		ns





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Parameter	Symbol	Test Conditions	Value			11.20
			Min	Тур	Max	Units
Input capacitance	C _{iss}	- V _{DS} =100V, V _{GS} =0V		1500		
Output capacitance	C _{oss}			200		pF
Reverse transfer capacitance	C _{rss}	1-100K12		2.2		
Effective output capacitance, energy related	C _{oss(er)}	V _{DS} =0V to 400V, V _{GS} =0V		146		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{DS} =0V to 400V, V _{GS} =0V		325		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =400V, V _{GS} =0V		11.7		μJ
Total gate charge	Q _G	– V _{DS} =400V, I _D =20A, –		43		nC
Gate-drain charge	Q _{GD}	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 20 \text{ A},$ - $V_{GS} = -5 \text{ V to } 12 \text{ V}$		11		
Gate-source charge	Q _{GS}	VGS 5710127		19		
Turn-on delay time	t _{d(on)}	V _{DS} =400V, I _D =20A, Gate		24		- ns
Rise time	t _r	Driver =-5V to +12V,		18		
Turn-off delay time	t _{d(off)}	Turn-on $R_{G,EXT}$ =8.5 Ω ,		44		
Fall time	t _f	Turn-off $R_{G,EXT}$ =22 Ω		9		-
Turn-on energy	E _{ON}	Inductive Load, FWD: same device with $V_{GS} = -5V, R_G = 10\Omega,$		144		
Turn-off energy	E _{OFF}			14		μJ
Total switching energy	E _{TOTAL}	T_=25°C		158		
Turn-on delay time	t _{d(on)}	_V _{DS} =400V, I _D =20A, Gate		21		
Rise time	t _r	Driver =-5V to +12V,		15		
Turn-off delay time	t _{d(off)}	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$		47		ns
Fall time	t _f			8		1
Turn-on energy	E _{ON}			118		
Turn-off energy	E _{OFF}			6		μJ
Total switching energy	E _{TOTAL}			124		1





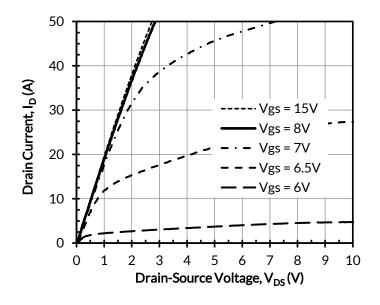
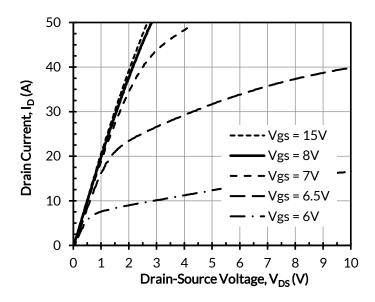


Figure 1. Typical output characteristics at $T_{\rm J}$ = - 55°C, tp < 250 μs



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Figure 2. Typical output characteristics at T $_{\rm J}$ = 25°C, tp < 250 μs

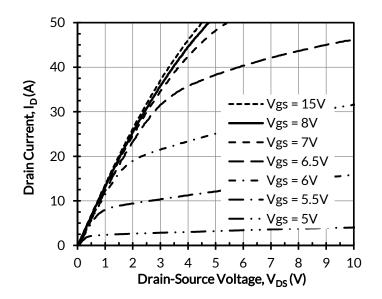


Figure 3. Typical output characteristics at T $_{\rm J}$ = 150°C, tp < 250 μs

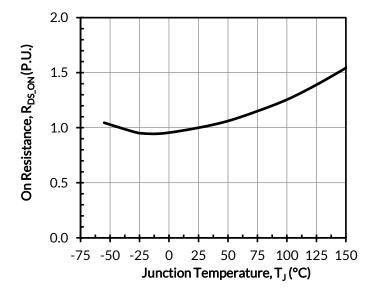


Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} =20A



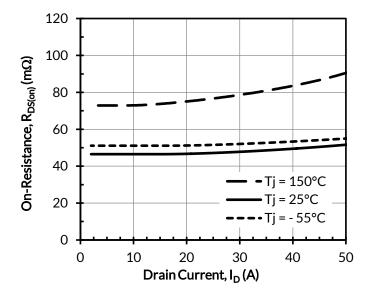
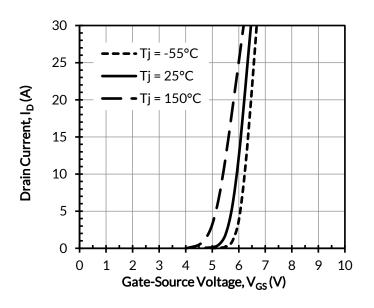


Figure 5. Typical drain-source on-resistances at $V_{\rm GS}$ = 12V



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Figure 6. Typical transfer characteristics at V_{DS} = 5V

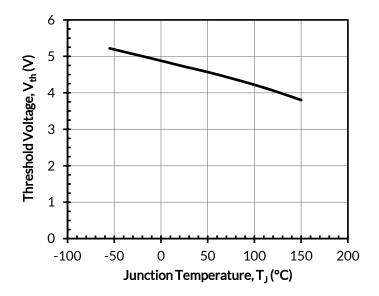


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_{D} = 10mA

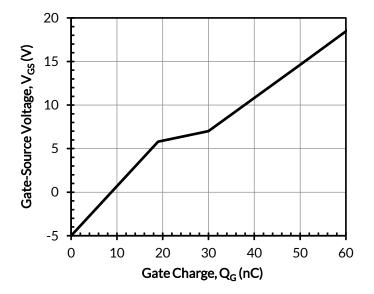


Figure 8. Typical gate charge at V_{DS} = 400V and I_{D} = 20A





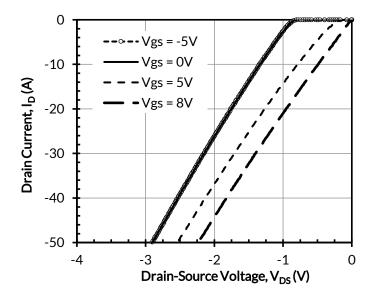


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

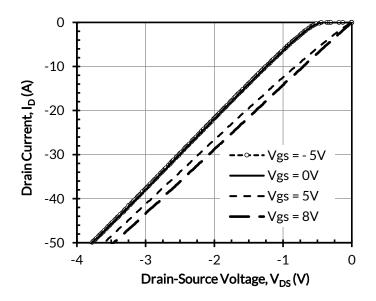


Figure 11. 3rd quadrant characteristics at T_J = 150°C

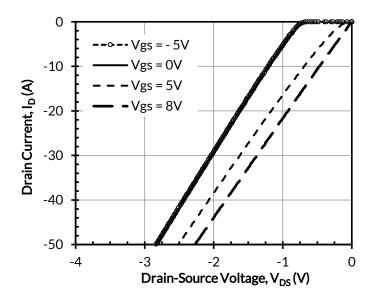


Figure 10. 3rd quadrant characteristics at T_J = 25°C

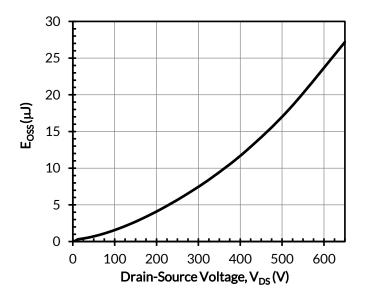


Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V



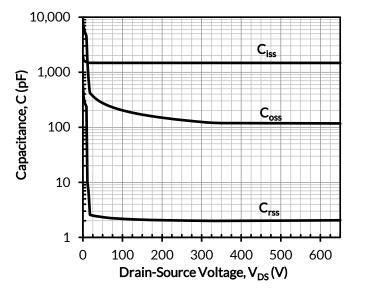
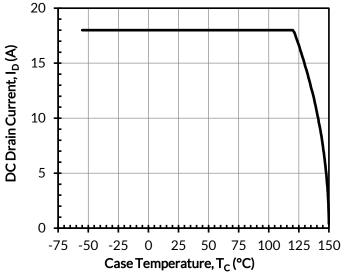


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V



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Figure 14. DC drain current derating

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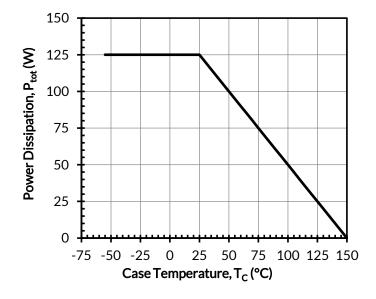


Figure 15. Total power dissipation

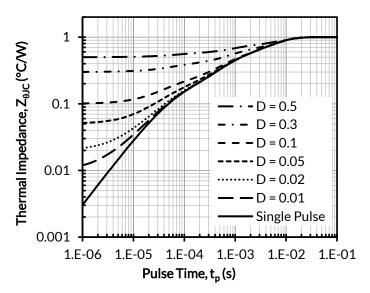


Figure 16. Maximum transient thermal impedance



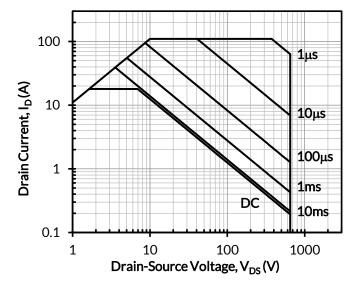
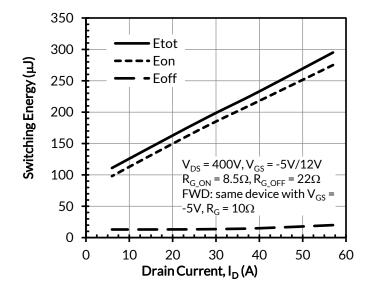


Figure 17. Safe operation area at T_C = 25°C, D = 0, Parameter t_p



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Figure 18. Clamped inductive switching energy vs. drain current at $T_J = 25^{\circ}C$

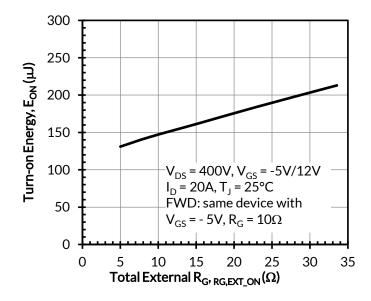


Figure 19. Clamped inductive switching turn-on energy vs. $R_{G,\text{EXT_ON}}$

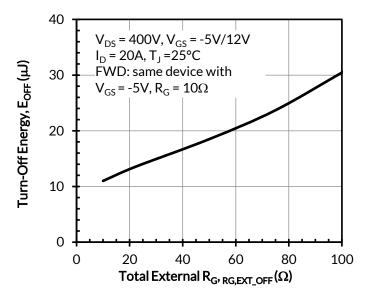


Figure 20. Clamped inductive switching turn-off energy vs. R_{G,EXT_OFF}



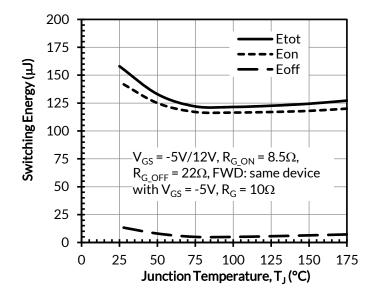
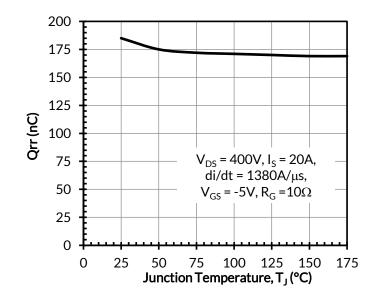


Figure 21. Clamped inductive switching energy vs. junction temperature at V_{DS} = 400V and I_D = 20A



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Figure 22. Reverse recovery charge Qrr vs. junction temperature

Applications Information

SiC FETs are enhancement-mode power switches formed by a high-voltage SiC depletion-mode JFET and a low-voltage silicon MOSFET connected in series. The silicon MOSFET serves as the control unit while the SiC JFET provides high voltage blocking in the off state. This combination of devices in a single package provides compatibility with standard gate drivers and offers superior performance in terms of low on-resistance ($R_{DS(on)}$), output capacitance (C_{oss}), gate charge (Q_G), and reverse recovery charge (Qrr) leading to low conduction and switching losses. The SiC FETs also provide excellent reverse conduction capability eliminating the need for an external anti-parallel diode.

Like other high performance power switches, proper PCB layout design to minimize circuit parasitics is strongly recommended due to the high dv/dt and di/dt rates. An external gate resistor is recommended when the FET is working in the diode mode in order to achieve the optimum reverse recovery performance. For more information on SiC FET operation, see www.unitedsic.com.

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